

## 1. General description

Planar passivated Silicon Controlled Rectifier in a TO247 Plus plastic package intended for use in applications requiring very high inrush current capability and high thermal cycling performance

## 2. Features and benefits

- High junction operating temperature capability ( $T_{j(max)} = 150\text{ }^{\circ}\text{C}$ )
- Very high current surge capability
- Planar passivated for voltage ruggedness and reliability
- High thermal cycling performance
- High voltage capability

## 3. Applications

- Line rectifying 50/60 Hz
- Softstart AC motor control
- DC Motor control
- Power converter
- AC power control
- Lighting and temperature control
- Uninterruptible Power Supply (UPS)
- Solid State Relay (SSR)
- Traction battery charging

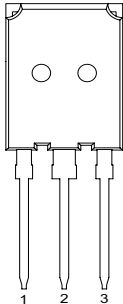
## 4. Quick reference data

Table 1. Quick reference data

| Symbol                         | Parameter                            | Conditions                                                                                                                                      | Notes | Values     |     |      | Unit               |
|--------------------------------|--------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------|-------|------------|-----|------|--------------------|
| $V_{DRM}$                      | repetitive peak off-state voltage    |                                                                                                                                                 |       | 1600       |     |      | V                  |
| $I_{T(RMS)}$                   | RMS on-state current                 | half sine wave; $T_{mb} \leq 102\text{ }^{\circ}\text{C}$ ;<br><a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>         |       | 160        |     |      | A                  |
| $I_{TSM}$                      | non-repetitive peak on-state current | half sine wave; $T_{j(init)} = 25\text{ }^{\circ}\text{C}$ ; $t_p = 10\text{ ms}$ ;<br><a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a>          |       | 1100       |     |      | A                  |
|                                |                                      | half sine wave; $T_{j(init)} = 25\text{ }^{\circ}\text{C}$ ; $t_p = 8.3\text{ ms}$                                                              |       | 1210       |     |      | A                  |
| $T_j$                          | operating junction temperature       |                                                                                                                                                 |       | -40 to 150 |     |      | $^{\circ}\text{C}$ |
| Symbol                         | Parameter                            | Conditions                                                                                                                                      | Notes | Min        | Typ | Max  | Unit               |
| <b>Static characteristics</b>  |                                      |                                                                                                                                                 |       |            |     |      |                    |
| $I_{GT}$                       | gate trigger current                 | $V_D = 12\text{ V}$ ; $I_T = 0.2\text{ A}$ ; $T_j = 25\text{ }^{\circ}\text{C}$ ;<br><a href="#">Fig. 7</a>                                     |       | 15         | -   | 100  | mA                 |
| $I_H$                          | holding current                      | $V_D = 12\text{ V}$ ; $T_j = 25\text{ }^{\circ}\text{C}$ ; <a href="#">Fig. 9</a>                                                               |       | -          | -   | 200  | mA                 |
| $V_T$                          | on-state voltage                     | $I_T = 100\text{ A}$ ; $T_j = 25\text{ }^{\circ}\text{C}$ ; <a href="#">Fig. 11</a>                                                             |       | -          | -   | 1.50 | V                  |
| <b>Dynamic characteristics</b> |                                      |                                                                                                                                                 |       |            |     |      |                    |
| $dV_D/dt$                      | rate of rise of off-state voltage    | $V_{DM} = 1072\text{ V}$ ; ( $V_{DM} = 67\%$ of $V_{DRM}$ );<br>exponential waveform; gate open circuit;<br>$T_j = 150\text{ }^{\circ}\text{C}$ |       | 1500       | -   | -    | V/ $\mu\text{s}$   |

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description                       | Simplified outline                                                                 | Graphic symbol                                                                      |
|-----|--------|-----------------------------------|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
| 1   | K      | cathode                           |  |  |
| 2   | A      | anode                             |                                                                                    |                                                                                     |
| 3   | G      | gate                              |                                                                                    |                                                                                     |
| mb  | A      | mounting base; connected to anode |                                                                                    |                                                                                     |

6. Ordering information

Table 3. Ordering information

| Type number    | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date |
|----------------|--------------|-----------------------|----------------|------------------------|-----------------|--------------------|
| TYN100WP-1600T | TO247P       | TYN100WP-1600TQ       | Tube           | 30                     | TO247PN         | 25-Jun-2024        |

7. Marking

Table 4. Marking codes

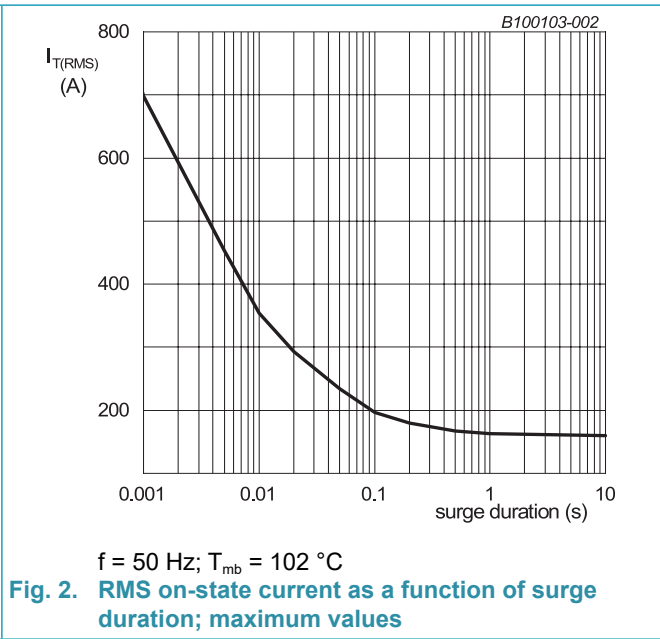
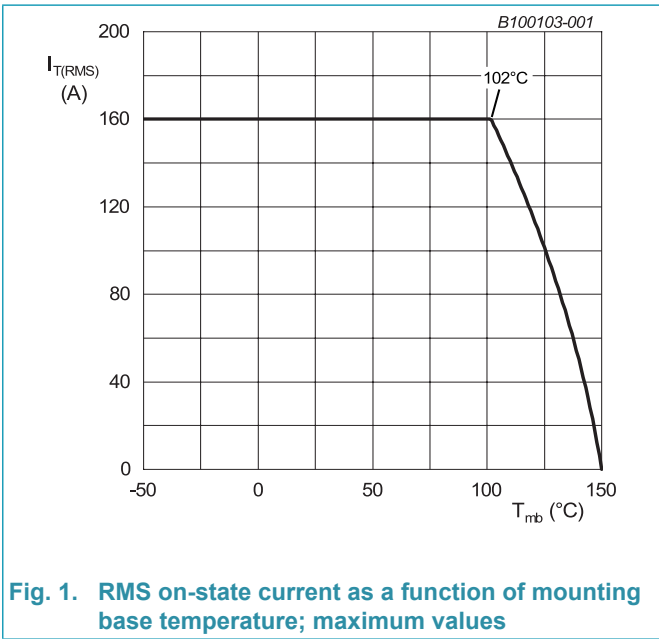
| Type number    | Marking codes     |
|----------------|-------------------|
| TYN100WP-1600T | TYN100WP<br>1600T |

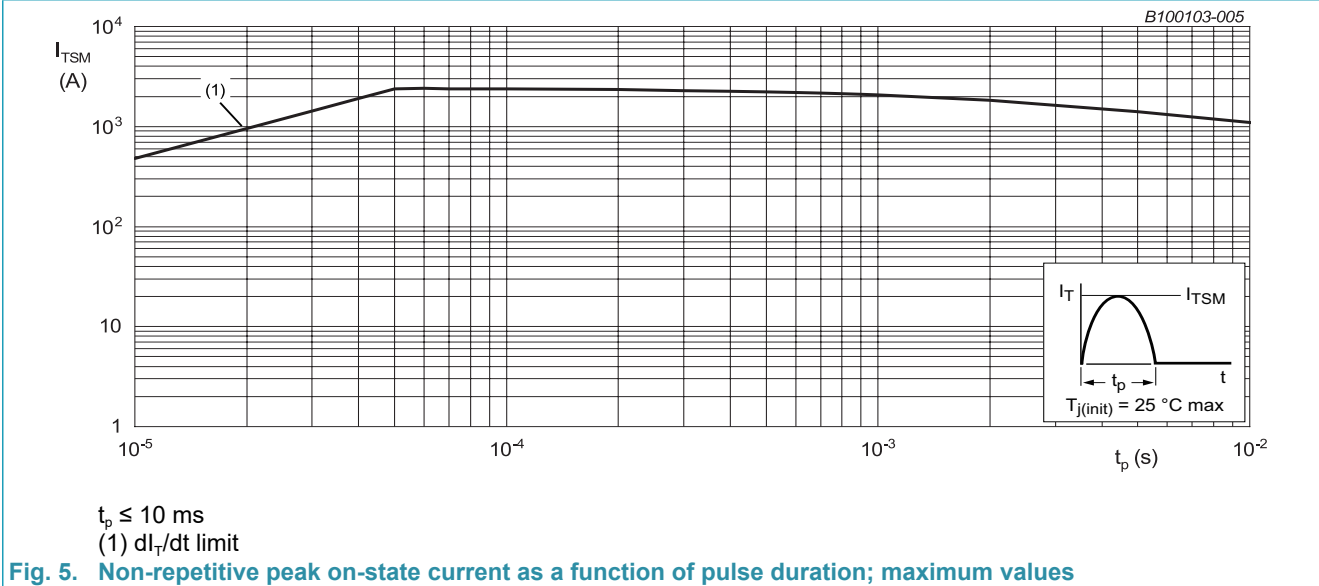
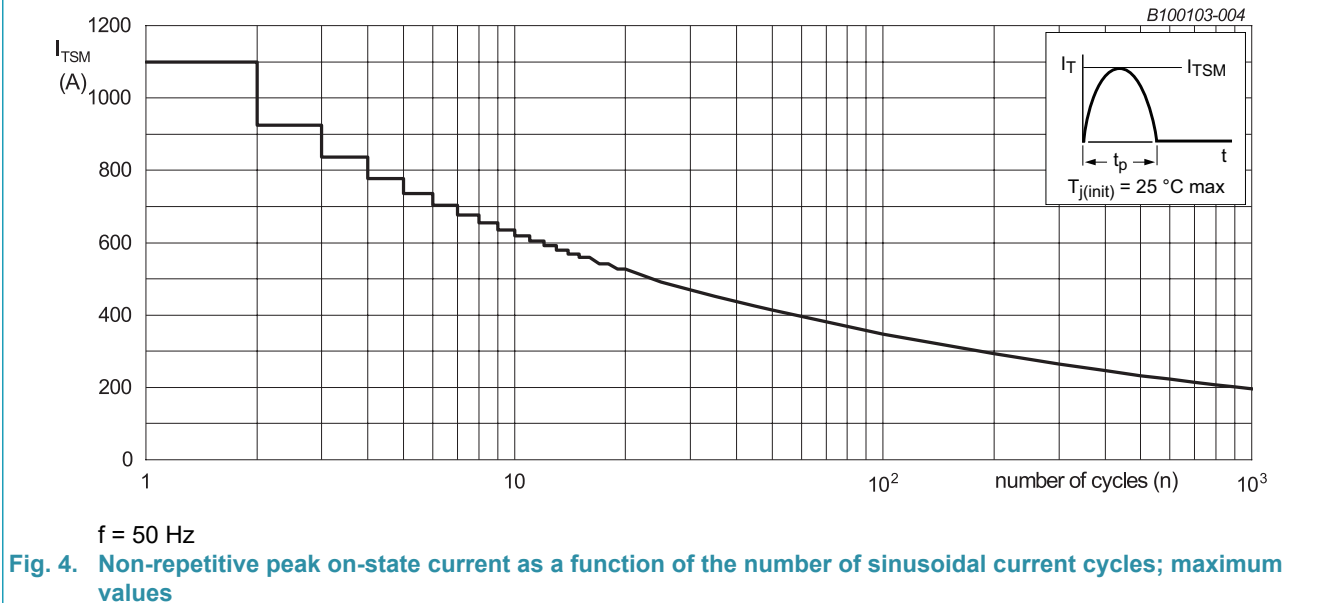
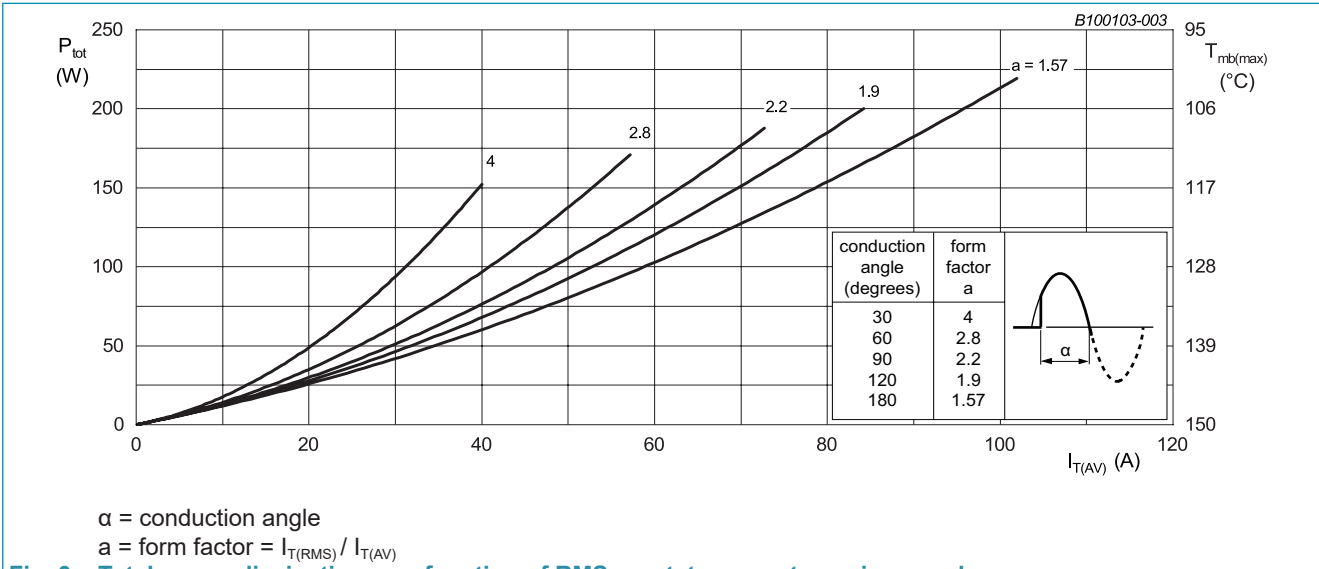
## 8. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol       | Parameter                            | Conditions                                                                                                                                    | Notes | Values     | Unit                   |
|--------------|--------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------|-------|------------|------------------------|
| $V_{DRM}$    | repetitive peak off-state voltage    |                                                                                                                                               |       | 1600       | V                      |
| $V_{RRM}$    | repetitive peak reverse voltage      |                                                                                                                                               |       | 1600       | V                      |
| $I_{T(AV)}$  | average on-state current             | half sine wave; $T_{mb} \leq 102\text{ }^{\circ}\text{C}$ ;                                                                                   |       | 100        | A                      |
| $I_{T(RMS)}$ | RMS on-state current                 | half sine wave; $T_{mb} \leq 102\text{ }^{\circ}\text{C}$ ;<br><a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>       |       | 160        | A                      |
| $I_{TSM}$    | non-repetitive peak on-state current | half sine wave; $T_{j(\text{init})} = 25\text{ }^{\circ}\text{C}$ ; $t_p = 10\text{ ms}$ ;<br><a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a> |       | 1100       | A                      |
|              |                                      | half sine wave; $T_{j(\text{init})} = 25\text{ }^{\circ}\text{C}$ ; $t_p = 8.3\text{ ms}$                                                     |       | 1210       | A                      |
| $I^2t$       | $I^2t$ for fusing                    | $t_p = 10\text{ ms}$ ; sine-wave pulse                                                                                                        |       | 6050       | $\text{A}^2\text{s}$   |
| $di_T/dt$    | rate of rise of on-state current     | $I_G = 200\text{ mA}$                                                                                                                         |       | 200        | $\text{A}/\mu\text{s}$ |
| $I_{GM}$     | peak gate current                    |                                                                                                                                               |       | 10         | A                      |
| $V_{GRM}$    | peak reverse gate voltage            |                                                                                                                                               |       | 5          | V                      |
| $P_{GM}$     | peak gate power                      |                                                                                                                                               |       | 20         | W                      |
| $P_{G(AV)}$  | average gate power                   | over any 20 ms period                                                                                                                         |       | 0.5        | W                      |
| $T_{stg}$    | storage temperature                  |                                                                                                                                               |       | -40 to 150 | $^{\circ}\text{C}$     |
| $T_j$        | operating junction temperature       |                                                                                                                                               |       | -40 to 150 | $^{\circ}\text{C}$     |

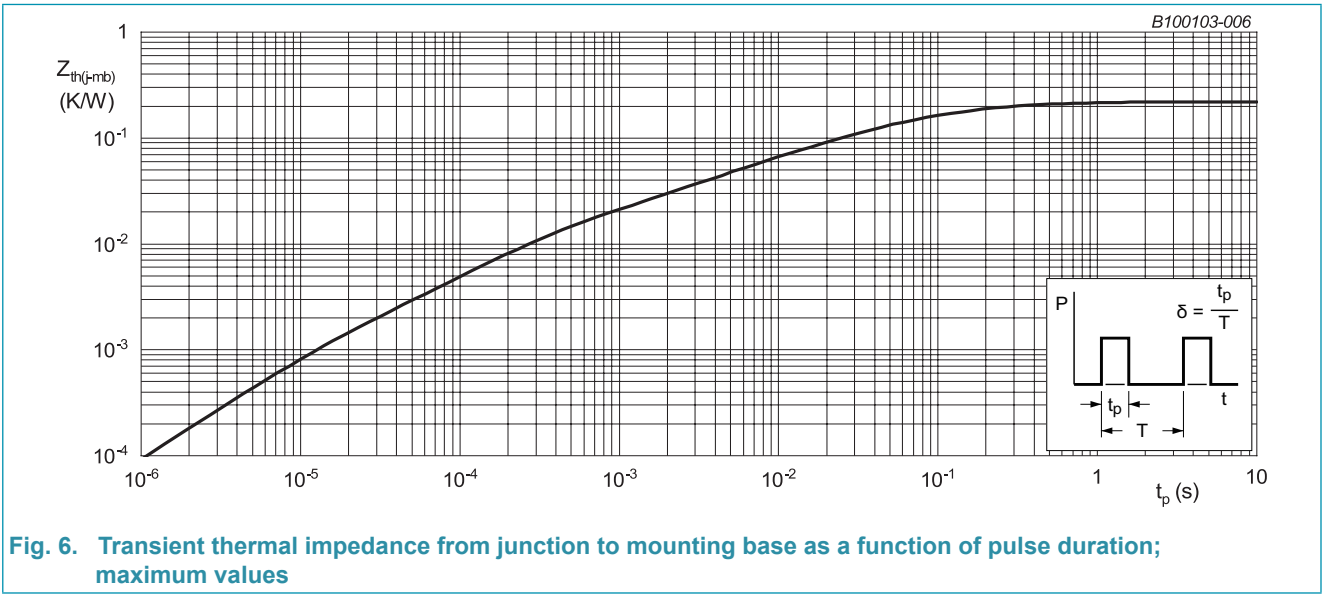




9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter                                         | Conditions             | Notes | Min | Typ | Max  | Unit |
|----------------|---------------------------------------------------|------------------------|-------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | <a href="#">Fig. 6</a> |       | -   | -   | 0.22 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | in free air            |       | -   | 45  | -    | K/W  |



10. Characteristics

Table 7. Characteristics

| Symbol                  | Parameter                         | Conditions                                                                                                                                                                                                                                                  | Notes | Min  | Typ  | Max  | Unit |
|-------------------------|-----------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|------|------|------|------|
| Static characteristics  |                                   |                                                                                                                                                                                                                                                             |       |      |      |      |      |
| I <sub>GT</sub>         | gate trigger current              | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.2 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 7</a>                                                                                                                                                               |       | 15   | -    | 100  | mA   |
| I <sub>L</sub>          | latching current                  | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.2 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 8</a>                                                                                                                                                               |       | -    | -    | 300  | mA   |
| I <sub>H</sub>          | holding current                   | V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <a href="#">Fig. 9</a>                                                                                                                                                                                       |       | -    | -    | 200  | mA   |
| V <sub>T</sub>          | on-state voltage                  | I <sub>T</sub> = 100 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 11</a>                                                                                                                                                                                     |       | -    | -    | 1.50 | V    |
| V <sub>GT</sub>         | gate trigger voltage              | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.2 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 10</a>                                                                                                                                                              |       | -    | 0.7  | 2.0  | V    |
|                         |                                   | V <sub>D</sub> = 1600 V; I <sub>T</sub> = 0.2 A; T <sub>j</sub> = 150 °C                                                                                                                                                                                    |       | 0.25 | 0.45 | -    | V    |
| I <sub>D</sub>          | off-state current                 | V <sub>D</sub> = 1600 V; T <sub>j</sub> = 25 °C                                                                                                                                                                                                             |       | -    | -    | 100  | μA   |
|                         |                                   | V <sub>D</sub> = 1600 V; T <sub>j</sub> = 150 °C                                                                                                                                                                                                            |       | -    | -    | 15   | mA   |
| I <sub>R</sub>          | reverse current                   | V <sub>D</sub> = 1600 V; T <sub>j</sub> = 25 °C                                                                                                                                                                                                             |       | -    | -    | 100  | μA   |
|                         |                                   | V <sub>D</sub> = 1600 V; T <sub>j</sub> = 150 °C                                                                                                                                                                                                            |       | -    | -    | 15   | mA   |
| Dynamic characteristics |                                   |                                                                                                                                                                                                                                                             |       |      |      |      |      |
| dV <sub>D</sub> /dt     | rate of rise of off-state voltage | V <sub>DM</sub> = 1072 V; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit; T <sub>j</sub> = 150 °C                                                                                                                    |       | 1500 | -    | -    | V/μs |
| t <sub>gt</sub>         | gate-controlled turn-on time      | I <sub>TM</sub> = 50 A; V <sub>D</sub> = 800 V; I <sub>G</sub> = 0.2 A; dI <sub>G</sub> /dt = 5 A/μs; T <sub>j</sub> = 25 °C                                                                                                                                |       | -    | 2    | -    | μs   |
| t <sub>q</sub>          | commutated turn-off time          | V <sub>DM</sub> = 1072 V; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); I <sub>TM</sub> = 100 A; V <sub>R</sub> = 25 V; (dI <sub>T</sub> /dt) <sub>M</sub> = 30 A/μs; dV <sub>D</sub> /dt = 50 V/μs; R <sub>GK(ext)</sub> = 100 kΩ; T <sub>j</sub> = 125 °C |       | -    | 150  | -    | μs   |

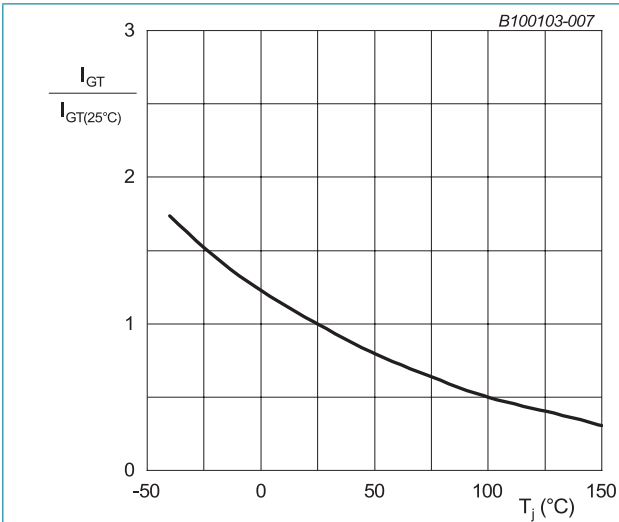


Fig. 7. Normalized gate trigger current as a function of junction temperature

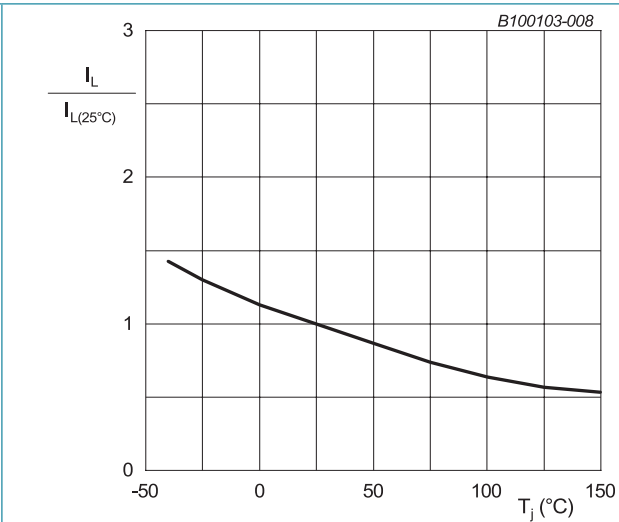


Fig. 8. Normalized latching current as a function of junction temperature

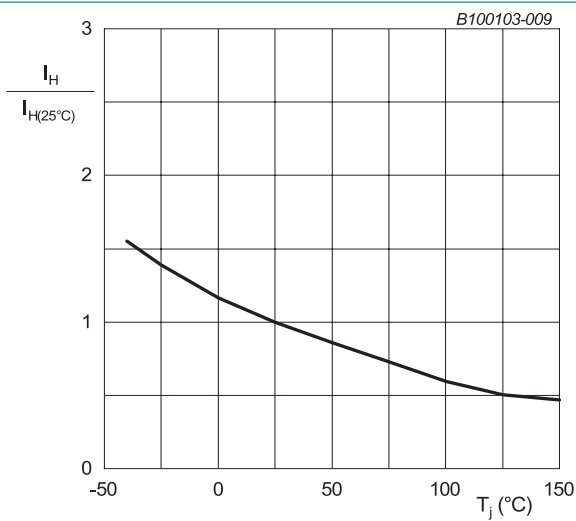


Fig. 9. Normalized holding current as a function of junction temperature

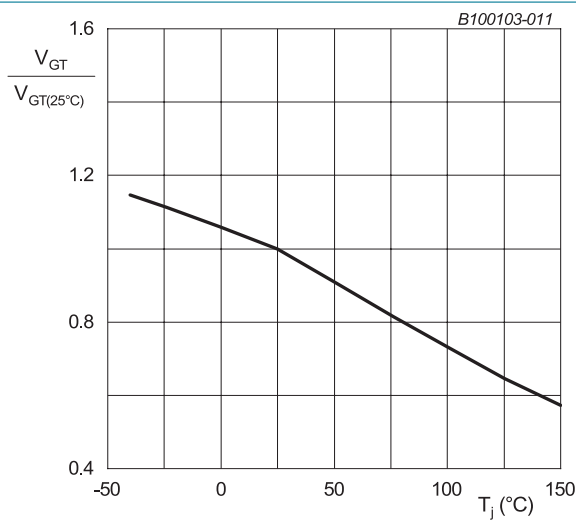
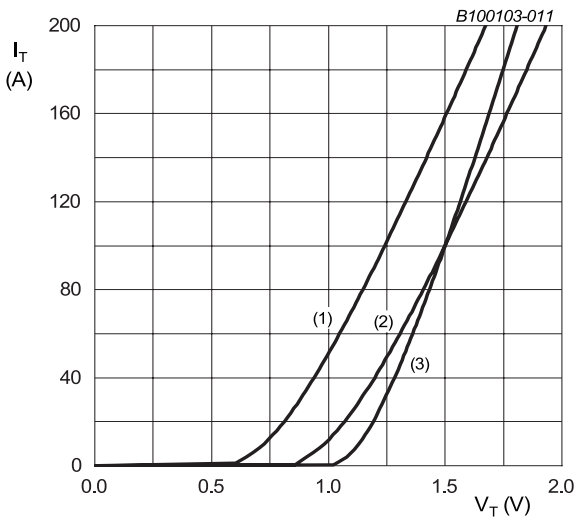


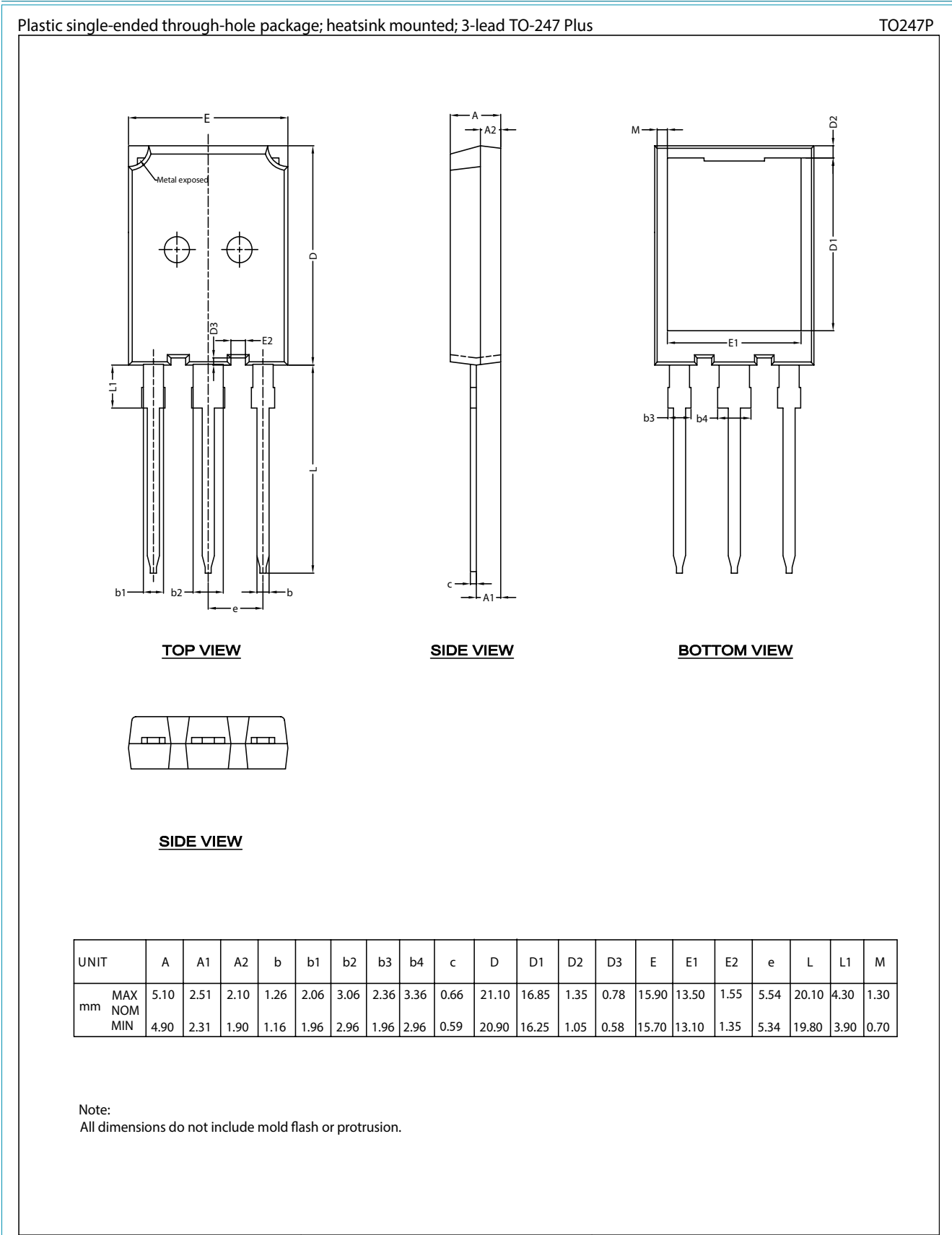
Fig. 10. Normalized gate trigger voltage as a function of junction temperature



$V_o = 1.083\text{ V}$ ;  $R_s = 0.0043\ \Omega$   
(1)  $T_j = 150^\circ\text{C}$ ; typical values  
(2)  $T_j = 150^\circ\text{C}$ ; maximum values  
(3)  $T_j = 25^\circ\text{C}$ ; maximum values

Fig. 11. On-state current as a function of on-state voltage

11. Package outline



# 12. Legal information

## Data sheet status

| Document status [1][2]         | Product status [3] | Definition                                                                            |
|--------------------------------|--------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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13. Contents

1. General description..... 1

2. Features and benefits ..... 1

3. Applications ..... 1

4. Quick reference data ..... 1

5. Pinning information..... 2

6. Ordering information..... 2

7. Marking..... 2

8. Limiting values ..... 3

9. Thermal characteristics ..... 5

10. Characteristics..... 6

11. Package outline ..... 8

12. Legal information ..... 9

13. Contents ..... 11

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For sales office addresses, please send an email to: [salesaddresses@ween-semi.com](mailto:salesaddresses@ween-semi.com)

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